

<b>Notice of References Cited</b>	Application/Control No. 10/731,131		Applicant(s)/Patent Under Reexamination KITAMURA ET AL.	
	Examiner Eric Hug		Art Unit 1731	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,880,456	04-2005	Viljanmaa, Mika	100/41
*	B	US-6,776,744	08-2004	Shieh, Yang T.	492/56
*	C	US-6,253,671	07-2001	Kayser, Franz	100/35
*	D	US-6,214,752	04-2001	Sakuma, Norio	442/59
*	E	US-6,136,151	10-2000	Davenport et al.	162/306
*	F	US-5,304,267	04-1994	Vrotacoe et al.	156/86
*	G	US-5,215,013	06-1993	Vrotacoe et al.	101/217
*	H	US-5,134,010	07-1992	Schiel, Christian	428/113
*	T	US-4,770,928	09-1988	Gaworowski et al.	442/221
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 02/075049	09-2002	PCT	Viljanmaa	D21G 1/02
	O	DE 199 56 352	06-2001	Germany	Schaefer	D21F 3/08
	P	DE 196 54 751	07-1998	Germany	Steiner	B30B 9/24
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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